

Notice of References Cited	Application/Control No. 10/509,519	Applicant(s)/Patent Under Reexamination HAYES ET AL.	
	Examiner Sun Jae Y. Loewe	Art Unit 1609	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	CAPLUS AN 1996:369699; Kiri et al., published 1996 ✓
	V	Kubo et al., CAPLUS AN 1994:569871, published 1994 ✓
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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